## Notice of References Cited Application/Control No. 10/768,505 Applicant(s)/Patent Under Reexamination HARWOOD ET AL. Examiner Sanh D. Phu Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2006/0050018	03-2006	Hutzel et al.	345/060
*	В	US-2001/0016501	08-2001	KING, JOSEPH D.	455/556
*	С	US-2005/0014468	01-2005	Salokannel et al.	455/041.2
*	D	US-6,396,408	05-2002	Drummond et al.	340/815.4
*	E	US-2002/0146999	10-2002	Witte, Markus Valter	455/345
*	F	US-2002/0107010	08-2002	Witte et al.	455/418
*	G	US-2004/0110472	06-2004	Witkowski et al.	455/041.2
*	Н	US-2001/0034754	10-2001	Elwahab et al.	709/201
*	ı	US-2006/0184456	08-2006	de Janasz, Christopher G.	705/072
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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